Se	arch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/944,332	SHEN ET AL.	
Examiner	Art Unit	
Qi Han	2626	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
·	DATE	EXMR
Rich Dorvil NPL search: reference title search, by EIC	8/10/2006	QH
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